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# RF, Microwave, and Millimeter Wave Devices and Circuits and Their Applications

Guest Editor

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## **Message from the Guest Editor**

Dear Colleagues,

The recent progress in the development of cost-effective and compact high frequency circuits in the RF, microwave, and millimeter wave domains has significantly broadened their applications. While many of these technologies were only used in military applications several decades ago, with the new developments, their use in various civilian applications is growing rapidly. The objective of this Special Issue is to provide an overview of the current research on "RF, Microwave, and Millimeter Wave Devices and Circuits and Their Applications", highlighting the latest developments and innovations in modern applications, including, but not limited to, the following:

- Imaging
- Microwave circuits
- Millimeter wave circuits
- Oscillators
- Radar
- Resonators
- RF circuits
- Sensors
- Wearable sensing
- Wireless power transfer











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### **Editor-in-Chief**

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## **Message from the Editor-in-Chief**

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